Applicant(s)/Patent Under Application/Control No. Reexamination 10/604,316 KELLEY ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2131 Shin-Hon Chen **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name * Country Code-Number-Kind Code MM-YYYY 709/206 * 08-2003 Peled et al. US-2003/0149732 709/207 * US-2004/0186894 09-2004 Jhingan et al. В 705/059 * Cahill et al. 02-2005 US-2005/0038750 С 709/202 Thorne et al. * 09-1999 US-5,958,005 D 709/206 Fellenstein et al. * 01-2004 US-2004/0019644 US-US-G US-Н US-US-US-US-US-FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification * **MM-YYYY** Country Code-Number-Kind Code N 0 Q R S **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U V W X

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.